

# SN54ABT646A, SN74ABT646A OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS

SCBS069G – JULY 1991 – REVISED MAY 1997

- State-of-the-Art **EPIC-II<sup>TM</sup>** BiCMOS Design Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical  $V_{OLP}$  (Output Ground Bounce) < 1 V at  $V_{CC} = 5$  V,  $T_A = 25^\circ\text{C}$
- High-Drive Outputs (–32-mA  $I_{OH}$ , 64-mA  $I_{OL}$ )
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), Ceramic Flat (W) Package, and Plastic (NT) and Ceramic (JT) DIPs

## description

These devices consist of bus-transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or from the internal registers. Data on the A or B bus is clocked into the registers on the low-to-high transition of the appropriate clock (CLKAB or CLKBA) input. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the 'ABT646A.

Output-enable ( $\overline{OE}$ ) and direction-control (DIR) inputs are provided to control the transceiver functions. In the transceiver mode, data present at the high-impedance port can be stored in either register or in both.

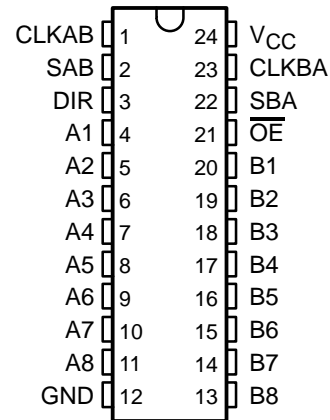
The select-control (SAB and SBA) inputs can multiplex stored and real-time (transparent mode) data. The direction control (DIR) determines which bus receives data when  $\overline{OE}$  is low. In the isolation mode ( $\overline{OE}$  high), A data can be stored in one register and/or B data can be stored in the other register.

When an output function is disabled, the input function is still enabled and can be used to store and transmit data. Only one of the two buses, A or B, can be driven at a time.

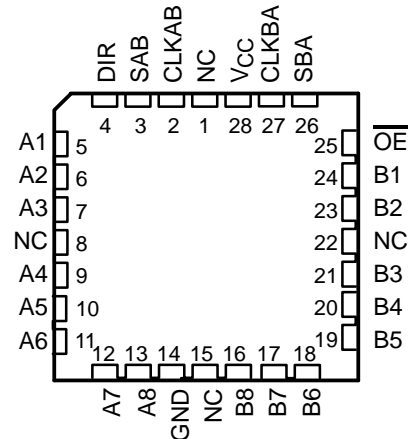
To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT646A is characterized for operation over the full military temperature range of  $-55^\circ\text{C}$  to  $125^\circ\text{C}$ . The SN74ABT646A is characterized for operation from  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ .

SN54ABT646A . . . JT OR W PACKAGE  
SN74ABT646A . . . DB, DW, NT, OR PW PACKAGE  
(TOP VIEW)



SN54ABT646A . . . FK PACKAGE  
(TOP VIEW)



NC – No internal connection



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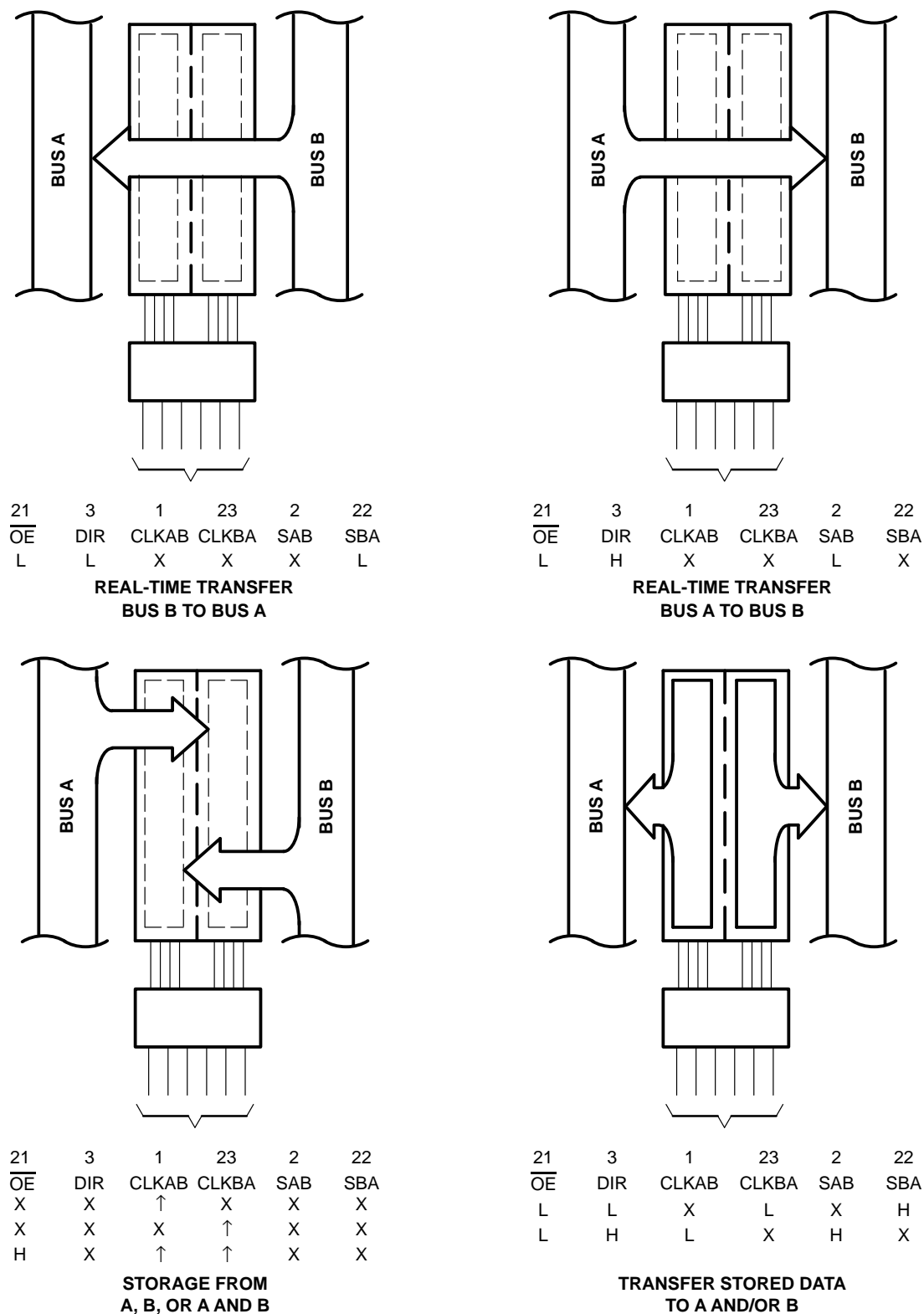
**TEXAS  
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Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.

**Figure 1. Bus-Management Functions**

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## OCTAL BUS TRANSCEIVERS AND REGISTERS

### WITH 3-STATE OUPUTS

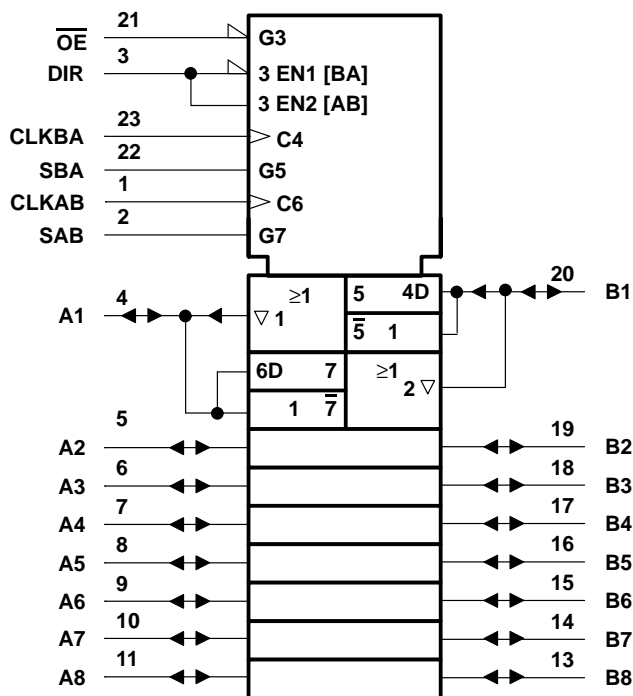
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FUNCTION TABLE

INPUTS						DATA I/Os		OPERATION OR FUNCTION
OE	DIR	CLKAB	CLKBA	SAB	SBA	A1–A8	B1–B8	
X	X	↑	X	X	X	Input	Unspecified†	Store A, B unspecified†
X	X	X	↑	X	X	Unspecified†	Input	Store B, A unspecified†
H	X	↑	↑	X	X	Input	Input	Store A and B data
H	X	H or L	H or L	X	X	Input disabled	Input disabled	Isolation, hold storage
L	L	X	X	X	L	Output	Input	Real-time B data to A bus
L	L	X	H or L	X	H	Output	Input	Stored B data to A bus
L	H	X	X	L	X	Input	Output	Real-time A data to B bus
L	H	H or L	X	H	X	Input	Output	Stored A data to B bus

† The data-output functions may be enabled or disabled by various signals at OE and DIR. Data-input functions are always enabled; i.e., data at the bus terminals is stored on every low-to-high transition of the clock inputs.

### logic symbol‡

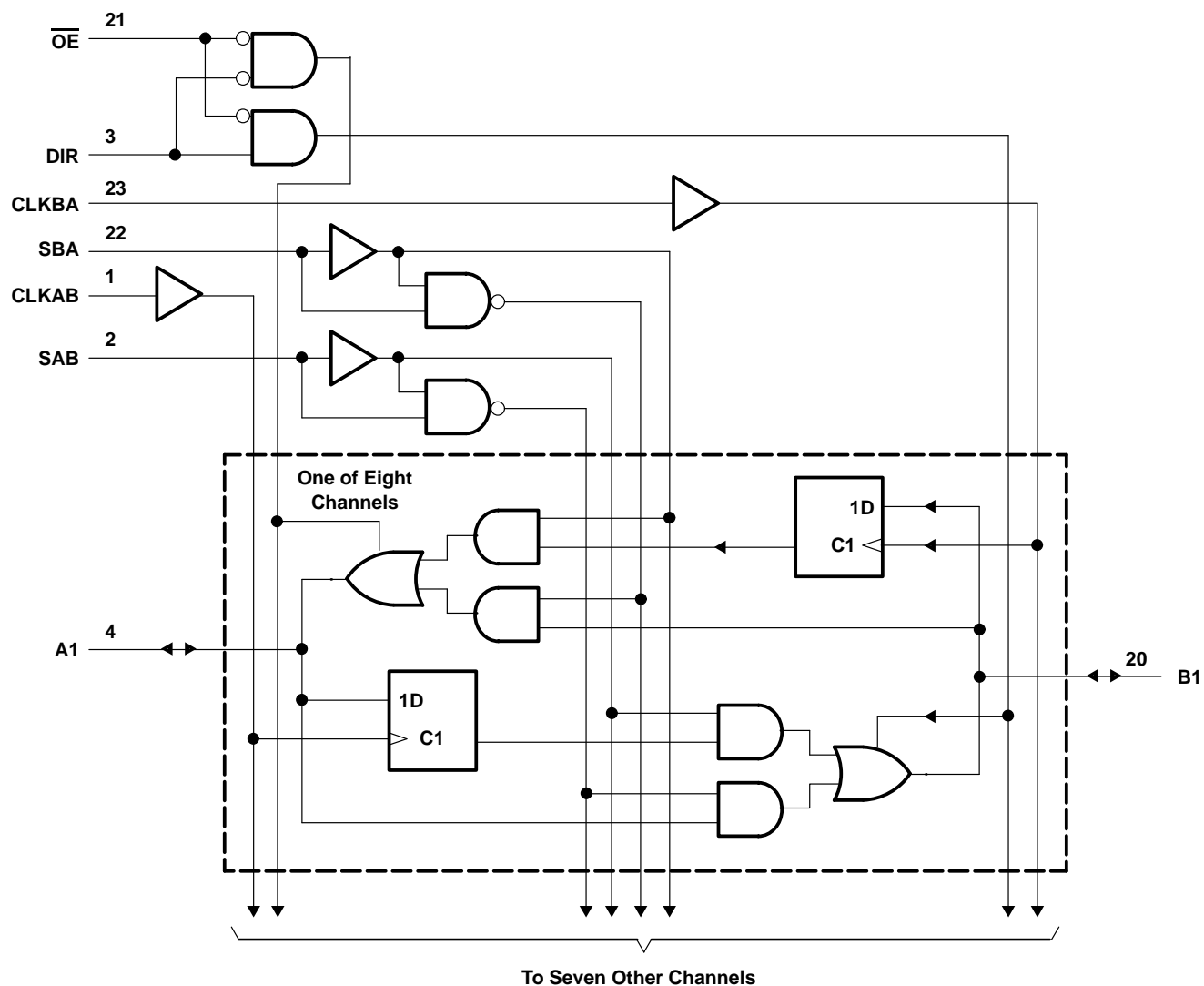


‡ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.  
Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.

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## logic diagram (positive logic)



Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.

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## OCTAL BUS TRANSCEIVERS AND REGISTERS

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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, $V_{CC}$	–0.5 V to 7 V
Input voltage range, $V_I$ (except I/O ports) (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, $V_O$	–0.5 V to 5.5 V
Current into any output in the low state, $I_O$ : SN54ABT646A	96 mA
SN74ABT646A	128 mA
Input clamp current, $I_{IK}$ ( $V_I < 0$ )	–18 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ )	–50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): DB package	104°C/W
DW package	81°C/W
NT package	67°C/W
PW package	120°C/W
Storage temperature range, $T_{stg}$	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.  
 2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

#### recommended operating conditions (see Note 3)

	SN54ABT646A		SN74ABT646A		UNIT
	MIN	MAX	MIN	MAX	
$V_{CC}$ Supply voltage	4.5	5.5	4.5	5.5	V
$V_{IH}$ High-level input voltage	2		2		V
$V_{IL}$ Low-level input voltage		0.8		0.8	V
$V_I$ Input voltage	0	$V_{CC}$	0	$V_{CC}$	V
$I_{OH}$ High-level output current		–24		–32	mA
$I_{OL}$ Low-level output current		48		64	mA
$\Delta t/\Delta v$ Input transition rise or fall rate		5		5	ns/V
$T_A$ Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.



# SN54ABT646A, SN74ABT646A

## OCTAL BUS TRANSCEIVERS AND REGISTERS

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**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER		TEST CONDITIONS		T <sub>A</sub> = 25°C			SN54ABT646A		SN74ABT646A		UNIT
				MIN	TYP†	MAX	MIN	MAX	MIN	MAX	
V <sub>IK</sub>		V <sub>CC</sub> = 4.5 V, I <sub>I</sub> = -18 mA		-1.2			-1.2		-1.2		V
V <sub>OH</sub>		V <sub>CC</sub> = 4.5 V, I <sub>OH</sub> = -3 mA		2.5			2.5		2.5		V
		V <sub>CC</sub> = 5 V, I <sub>OH</sub> = -3 mA		3			3		3		
		V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -24 mA	2			2				
			I <sub>OH</sub> = -32 mA	2*					2		
V <sub>OL</sub>		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 48 mA	0.55			0.55				V
			I <sub>OL</sub> = 64 mA	0.55*					0.55		
V <sub>hys</sub>				100							mV
I <sub>I</sub>	Control inputs	V <sub>CC</sub> = 5.5 V, V <sub>I</sub> = V <sub>CC</sub> or GND		±1			±1		±1		µA
	A or B ports			±100			±100		±100		
I <sub>OZH</sub> ‡		V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 2.7 V		10§			10§		10§		µA
I <sub>OZL</sub> ‡		V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 0.5 V		-10§			-10§		-10§		µA
I <sub>off</sub>		V <sub>CC</sub> = 0, V <sub>I</sub> or V <sub>O</sub> ≤ 4.5 V		±100					±100		µA
I <sub>CEX</sub>		V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 5.5 V	Outputs high	50			50		50		µA
I <sub>O</sub> ¶		V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 2.5 V		-50	-100	-180	-50	-180	-50	-180	mA
I <sub>CC</sub>		V <sub>CC</sub> = 5.5 V, I <sub>O</sub> = 0, V <sub>I</sub> = V <sub>CC</sub> or GND	Outputs high	250			250		250		µA
			Outputs low	30			30		30		mA
			Outputs disabled	250			250		250		µA
ΔI <sub>CC</sub> #		V <sub>CC</sub> = 5.5 V, One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND		1.5			1.5		1.5		mA
C <sub>i</sub>	Control inputs	V <sub>I</sub> = 2.5 V or 0.5 V		7							pF
C <sub>io</sub>	A or B ports	V <sub>O</sub> = 2.5 V or 0.5 V		12							pF

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

† All typical values are at V<sub>CC</sub> = 5 V.

‡ The parameters I<sub>OZH</sub> and I<sub>OZL</sub> include the input leakage current.

§ This data sheet limit may vary among suppliers.

¶ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

# This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.

**timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 2)**

		SN54ABT646A				UNIT
		V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C		MIN	MAX	
		MIN	MAX			
f <sub>clock</sub>	Clock frequency	0	125	0	125	MHz
t <sub>w</sub>	Pulse duration, CLK high or low	4		4		ns
t <sub>su</sub>	Setup time, A or B before CLKAB↑ or CLKBA↑	3		3.5		ns
t <sub>h</sub>	Hold time, A or B after CLKAB↑ or CLKBA↑	1.5		1.5		ns



# SN54ABT646A, SN74ABT646A

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 2)

		SN74ABT646A				UNIT
		V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C		MIN	MAX	
		MIN	MAX			
f <sub>clock</sub>	Clock frequency	0	125	0	125	MHz
t <sub>w</sub>	Pulse duration, CLK high or low	4		4		ns
t <sub>su</sub>	Setup time, A or B before CLKAB↑ or CLKBA↑	3		3		ns
t <sub>h</sub>	Hold time, A or B after CLKAB↑ or CLKBA↑	0		0		ns

switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50\text{ pF}$  (unless otherwise noted) (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54ABT646A				UNIT	
			V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			MIN		MAX
			MIN	TYP	MAX			
f <sub>max</sub>			125			125		MHz
t <sub>PLH</sub>	CLKBA or CLKAB	A or B	2.2	4	5.1	2.2	6.7	ns
t <sub>PHL</sub>			1.7	4	5.1	1.2	6.7	
t <sub>PLH</sub>	A or B	B or A	1.5	3	4.3	1.5	5	ns
t <sub>PHL</sub>			1.5	3.3	4.6	1.5	5.6	
t <sub>PLH</sub>	SAB or SBA†	B or A	1.5	4	5.7	1.5	7.8	ns
t <sub>PHL</sub>			1.5	3.6	4.9	1.5	6.2	
t <sub>PZH</sub>	$\overline{\text{OE}}$	A or B	1.5	4.3	5.3	1.5	7	ns
t <sub>PZL</sub>			3	5.8	8	3	10.5	
t <sub>PHZ</sub>	$\overline{\text{OE}}$	A or B	1.5	3.5	5.8	1	7.3	ns
t <sub>PLZ</sub>			1.5	3	4	1.5	5.7	
t <sub>PZH</sub>	DIR	A or B	1.5	4.5	5.7	1.5	7.3	ns
t <sub>PZL</sub>			2.5	6.5	9	2.5	11	
t <sub>PHZ</sub>	DIR	A or B	1.5	3.8	6.5	1	9	ns
t <sub>PLZ</sub>			1.5	3.8	4.7	1.2	6.7	

$\uparrow$  These parameters are measured with the internal output state of the storage register opposite that of the bus input.

# SN54ABT646A, SN74ABT646A

## OCTAL BUS TRANSCEIVERS AND REGISTERS

### WITH 3-STATE OUPUTS

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50$  pF (unless otherwise noted) (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN74ABT646A					UNIT
			V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			MIN	MAX	
			MIN	TYP	MAX			
f <sub>max</sub>			125			125		MHz
t <sub>PLH</sub>	CLKBA or CLKAB	A or B	2.2	4	5.1	2.2	5.6	ns
t <sub>PHL</sub>			1.7	4	5.1	1.7	5.6	
t <sub>PLH</sub>	A or B	B or A	1.5	3	4.3	1.5	4.8	ns
t <sub>PHL</sub>			1.5	3.3	4.6	1.5	5.4	
t <sub>PLH</sub>	SAB or SBA†	B or A	1.5	4	5.1	1.5	6.5	ns
t <sub>PHL</sub>			1.5	3.6	4.9	1.5	5.9	
t <sub>PZH</sub>	$\overline{OE}$	A or B	1.5	4.3	5.3	1.5	6.3	ns
t <sub>PZL</sub>			3	5.8	7.4	3	8.8	
t <sub>PHZ</sub>	$\overline{OE}$	A or B	1.5	3.5	4.5	1.5	5	ns
t <sub>PLZ</sub>			1.5	3	4	1.5	4.5	
t <sub>PZH</sub>	DIR	A or B	1.5	4.5	5.7	1.5	6.7	ns
t <sub>PZL</sub>			2.5	6.5	9	2.5	9.5	
t <sub>PHZ</sub>	DIR	A or B	1.5	3.8	5	1.5	5.7	ns
t <sub>PLZ</sub>			1.5	3.8	4.7	1.5	6	

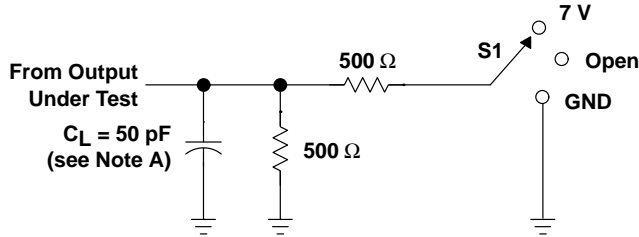
† These parameters are measured with the internal output state of the storage register opposite that of the bus input.



# SN54ABT646A, SN74ABT646A OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS

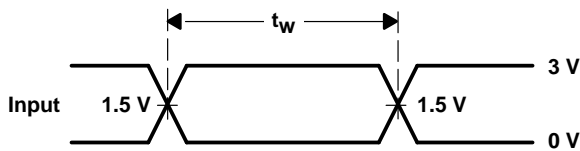
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## PARAMETER MEASUREMENT INFORMATION

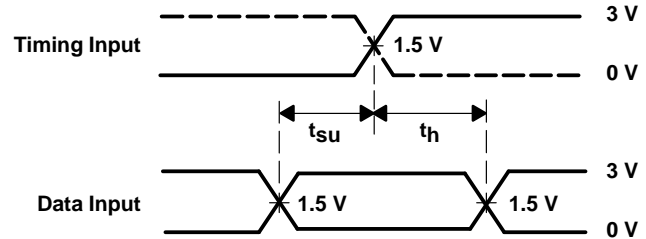


LOAD CIRCUIT

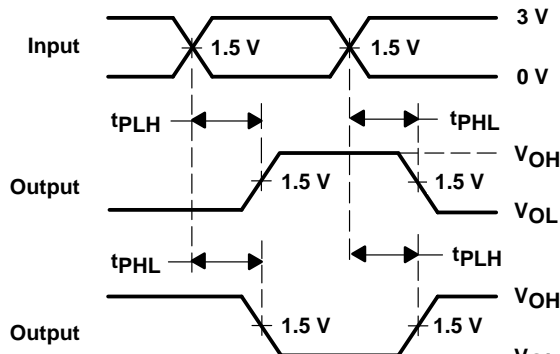
TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	7 V
$t_{PHZ}/t_{PZH}$	Open



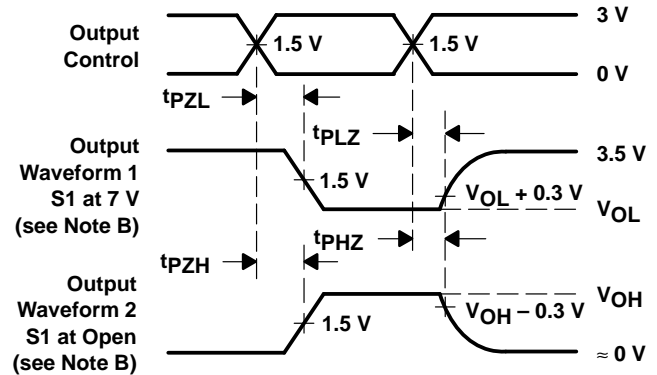
VOLTAGE WAVEFORMS  
PULSE DURATION



VOLTAGE WAVEFORMS  
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS  
PROPAGATION DELAY TIMES  
INVERTING AND NONINVERTING OUTPUTS



VOLTAGE WAVEFORMS  
ENABLE AND DISABLE TIMES  
LOW- AND HIGH-LEVEL ENABLING

- NOTES: A.  $C_L$  includes probe and jig capacitance.  
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.  
C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r \leq 2.5 \text{ ns}$ ,  $t_f \leq 2.5 \text{ ns}$ .  
D. The outputs are measured one at a time with one transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms

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